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Shenzhen, Guangdong, China 518057

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TEST REPORT

Application No.: SZEM1801000310CR

Applicant: Harman International Industries, Inc.

Address of Applicant: 8500 Balboa Boulevard, Northridge, California, 91329, United States

Manufacturer: Harman International Industries, Inc.

Address of Manufacturer: 8500 Balboa Boulevard, Northridge, California, 91329, United States

Factory: Shenzhen 3Nod Digital Technology Co., Ltd.

Address of Factory: Building D, No.8 Langhui Road, Tangxiayong Community, Songgang Street,

Baoan District, Shenzhen City, Guangdong Province, P.R.China

Equipment Under Test (EUT):

EUT Name: Bluetooth headset

Model No.: LIVE200BT FCC ID: APILIVE200BT

Trade mark: JBL

Standard(s): 47 CFR Part 1.1307, Part 2.1093,

KDB 447498 D01 General RF Exposure Guidance v06

Date of Receipt: 2018-01-11

Date of Test: 2018-01-16 to 2018-01-29

Date of Issue: 2018-02-02

Test Result: Pass*



EMC Laboratory Manager

The manufacturer should ensure that all products in series production are in conformity with the product sample detailed in this report. If the product in this report is used in any configuration other than that detailed in the report, the manufacturer must ensure the new system complies with all relevant standards. Any mention of SGS International Electrical Approvals or testing done by SGS International Electrical Approvals in connection with, distribution or use of the product described in this report must be approved by SGS International Electrical Approvals in writing.

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^{*} In the configuration tested, the EUT complied with the standards specified above.



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	Revision Record				
Version	Chapter	Date	Modifier	Remark	
01		2018-02-02		Original	

Authorized for issue by:		
	Bonson Wang	
	Benson Wang /Project Engineer	
	EvicFu	
	Eric Fu /Reviewer	



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2 Test Summary

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Item	Standard	Method	Requirement	Result
RF Exposure	47 CFR Part 1.1307, Part 2.1093, KDB 447498 D01 General RF Exposure Guidance v06	CFR 47 Part 2.1093	CFR 47 Part 2.1093	Pass*



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4 General Information

4.1 Details of E.U.T.

Power supply:	Lithium Ion Battery: 3.7V 170mAh (Charge by adapter)
Cable:	USB cable: 28cm unshielded
Bluetooth Version:	BT4.2 Dual mode
For BLE	
Operation Frequency	2402MHz to 2480MHz
Number of Channels	40
Channel Spacing	2MHz
Modulation Type	GFSK
Antenna Type	Integral Antenna
Antenna Gain	1.87dBi
For BT	
Operation Frequency	2402MHz to 2480MHz
Spectrum Spread Technology	Frequency Hopping Spread Spectrum(FHSS)
Modulation Type	GFSK, π/4DQPSK, 8DPSK
Number of Channels	79
Channel Spacing	1MHz
Antenna Type	Integral Antenna
Antenna Gain	1.87dBi

4.2 Description of Support Units

The EUT has been tested as an independent unit.

4.3 Measurement Uncertainty

No.	Item	Measurement Uncertainty
1	Radio Frequency	7.25 x 10 ⁻⁸
2	Duty cycle	0.37%
3	Occupied Bandwidth	3%
4	RF conducted power	0.75dB
5	RF power density	2.84dB
6	Conducted Spurious emissions	0.75dB
7	DE Dadistada assas	4.5dB (below 1GHz)
/	RF Radiated power	4.8dB (above 1GHz)
0	Dedicted Couries a principal test	4.5dB (Below 1GHz)
8	Radiated Spurious emission test	4.8dB (Above 1GHz)
9	Temperature test	1℃
10	Humidity test	3%
11	Supply voltages	1.5%
12	Time	3%



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4.4 Test Location

All tests were performed at:

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen Branch

No. 1 Workshop, M-10, Middle Section, Science & Technology Park, Shenzhen, Guangdong, China. 518057.

Tel: +86 755 2601 2053 Fax: +86 755 2671 0594

No tests were sub-contracted.

4.5 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

• CNAS (No. CNAS L2929)

CNAS has accredited SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab to ISO/IEC 17025:2005 General Requirements for the Competence of Testing and Calibration Laboratories (CNAS-CL01 Accreditation Criteria for the Competence of Testing and Calibration Laboratories) for the competence in the field of testing.

A2LA (Certificate No. 3816.01)

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory is accredited by the American Association for Laboratory Accreditation(A2LA). Certificate No. 3816.01.

VCCI

The 3m Fully-anechoic chamber for above 1GHz, 10m Semi-anechoic chamber for below 1GHz, Shielded Room for Mains Port Conducted Interference Measurement and Telecommunication Port Conducted Interference Measurement of SGS-CSTC Standards Technical Services Co., Ltd. have been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-20026, R-14188, C-12383 and T-11153 respectively.

• FCC -Designation Number: CN1178

SGS-CSTC Standards Technical Services Co., Ltd., Shenzhen EMC Laboratory has been recognized as an accredited testing laboratory.

Designation Number: CN1178. Test Firm Registration Number: 406779.

Industry Canada (IC)

Two 3m Semi-anechoic chambers and the 10m Semi-anechoic chamber of SGS-CSTC Standards Technical Services Co., Ltd. Shenzhen Branch EMC Lab have been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing with Registration No.: 4620C-1, 4620C-2, 4620C-3.

4.6 Deviation from Standards

None

4.7 Abnormalities from Standard Conditions

None



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5 Radio Spectrum Technical Requirement

5.1 RF Exposure

5.1.1 Test Requirement:

CFR 47 Part 2.1093

Limit:

The 1-g and 10-g SAR test exclusion thresholds for 100 MHz to 6 GHz at test separation distances ≤ 50 mm are determined by:

[(max. power of channel, including tune-up tolerance, mW) / (min. test separation distance, mm)] $\cdot [\sqrt{f(GHz)}] \le 3.0$ for 1-g SAR and ≤ 7.5 for 10-g extremity SAR, where

f(GHz) is the RF channel transmit frequency in GHz

Power and distance are rounded to the nearest mW and mm before calculation¹⁷

The result is rounded to one decimal place for comparison

The test exclusions are applicable only when the minimum test separation distance is ≤ 50 mm and for transmission frequencies between 100 MHz and 6 GHz. When the minimum test separation distance is < 5 mm, a distance of 5 mm is applied to determine SAR test exclusion

5.1.2 Conclusion

BT/BLE:

The Max. power (including tune-up toleranc 4.00 dBm on the lowest char	nne 2.48	GHz (*)
4.00 dBm logarithmic terms convert to numeric result is nearly 2.51 mW		
According to the formula. calculate the test exclusion thresholds:		
General RF Exposure = $\frac{\text{Max.Power of channel, including tune-up tolerance, mW}}{(min.test seneration distance, mm) * \sqrt{f_*(GH_2)}$		
(min. test separation atstance, min) * () (0112)		
General RF Exposure = $(2.51 \text{ mW} / 5 \text{ mm}) \times \sqrt{2.48 \text{ GHz}} = 0.79$	(1)	
SAR requirement:		
S = 3.0	(2)	
(1) < (2)		
So the SAR report is not required.		



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6 Photographs

6.1 EUT Constructional Details (EUT Photos)

Refer to Report No. SZEM1801000310CR for EUT internal and external photos.

- End of the Report -